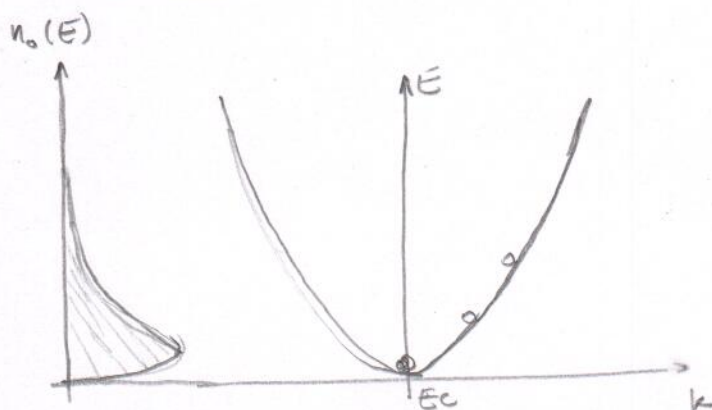


thermal velocity



electrons with high E have higher velocities

Electron velocity:

$$v_n(k) = \frac{1}{\hbar} \nabla_k E_n(k)$$

at bottom of the conduction band:

$$E = \frac{\hbar^2 k^2}{2m^*} = \frac{p^2}{2m^*}$$

p : momentum

$$\text{thus } v_n(k) = \frac{\hbar k}{m^*} = \frac{p}{m^*}$$

$$\Rightarrow p = \hbar k$$

classically: $p = m v$

$$v_e(E) = \sqrt{\frac{2(E - E_c)}{m^*}}$$

electron conductivity
effective mass

$\downarrow$
connects kinetic energy
with electron velocity

Average thermal velocity

$$\langle v_{th} \rangle = \frac{\int_{E_c}^{\infty} v_e(E) n_0(E) dE}{\int_{E_c}^{\infty} n_0(E) dE} \quad \therefore \text{average of all electron velocities at } E \text{ above } E_c$$

$$\langle v_{th} \rangle = \sqrt{\frac{2}{m^*}} \cdot \frac{\int_{E_c}^{\infty} \frac{(E - E_c)}{1 + \exp\left(\frac{E - E_F}{kT}\right)} dE}{\int_{E_c}^{\infty} \frac{\sqrt{E - E_c}}{1 + \exp\left(\frac{E - E_F}{kT}\right)} dE} = \sqrt{\frac{8kT}{\pi m^*}}$$

* derivation is on
needle, in the book
chapter

for Si at Room temperature

$$m_{ce}^* = 0.28 m_0 \Rightarrow \langle v_{th} \rangle = 2 \times 10^7 \text{ cm/s}$$

Mean free path (thermal)

$$l_{ce} = \frac{\pi \hbar}{4} \cdot \sqrt{v_{th}} \cdot \tau_{ce}$$

time
between
collisions

: energy independent since

$$\sqrt{v_{th}} \propto (E - E_c)^{1/2}$$

$$\tau \propto (E - E_c)^{-1/2}$$

$$\tau_{ce} \propto (E - E_c)^{-1/2}$$

Drift:

Under $\vec{E}$:

$$\vec{F} = -q \cdot \vec{E}$$

$$\vec{a} = - \frac{q \cdot \vec{E}}{m_{ee}^*}$$

$$\vec{v}_{\text{drift}} = - \frac{q \cdot \vec{E}}{m_{ee}^*} \cdot \tau_{ee} = - \mu_e \cdot \vec{E}$$

electrons move against $\vec{E}$

$$\left\{ \begin{array}{l} v_e^{\text{drift}} = - \mu_e \cdot E \\ v_h^{\text{drift}} = + \mu_h \cdot E \end{array} \right.$$



• We can define an electron mobility [$\text{cm}^2/\text{V.s}$]

Depends on strength of scattering mechanisms

Doping $\uparrow$ scattering $\uparrow$ $\mu \downarrow$ $v_{\text{drift}} \downarrow$

Mobility depends on:

$$\left\{ \begin{array}{l} \cdot 1/T \\ \cdot 1/m^* \\ \cdot 1/\text{scattering} \end{array} \right.$$

ionized impurities
acoustic phonons
optical phonons

* Example (page 3)

Drift current:

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$$I_e dt = n \cdot v_e dt \Rightarrow I_e = n v_e \quad \left[\text{cm}^{-3} \cdot \frac{\text{cm}}{\text{s}} \right]$$

$$J_e = -q \cdot n \cdot v_e = -q \cdot n \cdot (-\mu_e \cdot E) = q \cdot n \cdot \mu_e \cdot E$$

$$J_h = +q \cdot p \cdot v_h = q \cdot p \cdot \mu_h \cdot E$$

$$J = q (n \mu_e + p \mu_h) \cdot E$$

ohm's law for semiconductors.
 $V = R \cdot I \Rightarrow \frac{V}{L} = (R \cdot A) \frac{I}{A} \Rightarrow E = \rho \cdot J$

Consider: a n-type Si with a resistivity of $0.1 \Omega \text{ cm}$.

an applied electric field of 1000 V/cm

- what is the electron and hole drift velocity?
- what is the total drift current density?

$$0.1 \Omega \text{ cm} \Rightarrow N_D \approx 9 \times 10^{16} \text{ cm}^{-3}$$

$$n_i = 1.5 \times 10^{10} \text{ cm}^{-3}$$

From the
figure

Assuming $n_0 \approx N_D \Rightarrow P_0 = \frac{(1.5 \times 10^{10})^2}{9 \times 10^{16}} = 2.5 \times 10^3 \text{ cm}^{-3}$

From the second plot:

$$\mu_e = 750 \text{ cm}^2/\text{Vs}$$

$$\mu_h = 460 \text{ cm}^2/\text{Vs}$$

Thus:

$$v_e^{\text{drift}} = -\mu_e \cdot E = -750 \text{ cm}^2/\text{Vs} \times 1000 \text{ V/cm} = -7.5 \times 10^5 \text{ cm/s}$$

$$v_h^{\text{drift}} = +\mu_h \cdot E = 460 \text{ cm}^2/\text{Vs} \times 1000 \text{ V/cm} = 4.6 \times 10^5 \text{ cm/s}$$

Drift current densities:

$$J_e = -q \cdot n \cdot v_e^{\text{drift}} = 1.6 \times 10^{-19} \text{ C} \times 9 \times 10^{16} \text{ cm}^{-3} \times 7.5 \times 10^5 \text{ cm/s} = 1.1 \times 10^4 \text{ A/cm}^2$$

$$J_h = q \cdot p \cdot v_h^{\text{drift}} = 1.6 \times 10^{-19} \text{ C} \times 2.5 \times 10^3 \text{ cm}^{-3} \times 4.6 \times 10^5 \text{ cm/s} = 1.8 \times 10^{-11} \text{ A/cm}^2$$

much smaller than v_e^{drift}
 $\Rightarrow$ not in saturation

very small since
these are minority
carriers.

$$\therefore J = J_e + J_h \approx 1.2 \times 10^4 \text{ A/cm}^2$$

Energy band diagram under Electric field

Potential Energy: $E_p = -q \cdot \phi$

electrons go down the energy potential profile

$\Rightarrow$ trade E_p by Kinetic energy.

$\Rightarrow$ balance between phonon emission and absorption is broken.

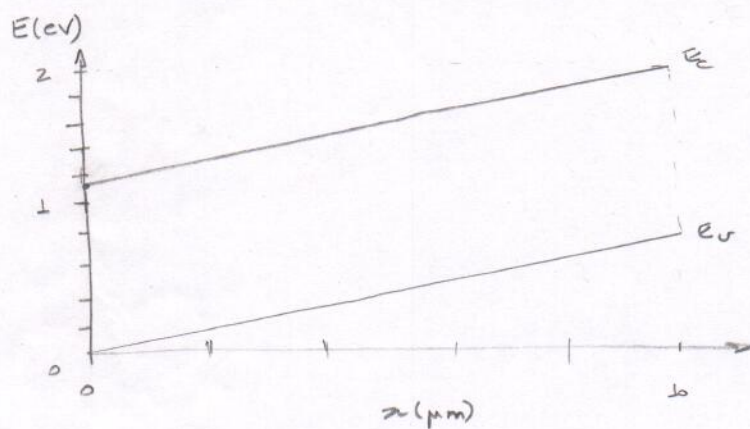
• more likely to emit phonons than absorb.

$\Rightarrow$ path to restore T.E.

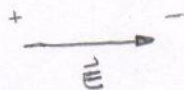
#2

$$\begin{cases} E_c + E_{ref} = E_p = -q \cdot \phi \\ \vec{E} = -\frac{d\phi}{dx} = \frac{1}{q} \cdot \frac{dE_c}{dx} = \frac{1}{q} \frac{dE_v}{dx} \end{cases}$$

Example: What is the magnitude and direction of $\vec{E}$



$$|\vec{E}| = \frac{1}{q} \cdot \frac{dE_c}{dx} = \frac{1}{e} \cdot \frac{2 - 1.1}{10 \times 10^{-6} \text{ cm}} = 900 \text{ V/cm}$$



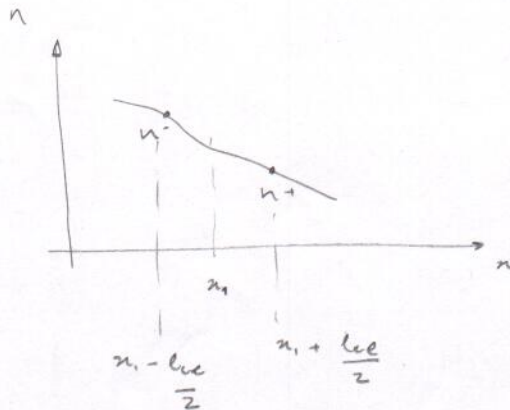
Diffusion :

Very common process :

• drop of cream in coffee

• $\bar{E}$ and holes get kicked out by vibrating atoms. (at a certain T)

• at $T=0 \Rightarrow$ no diffusion



flux:

$$f_c(x_1) = \frac{n^-}{2} \cdot v_{the} - \frac{n^+}{2} \cdot v_{the} = -\frac{1}{2} v_{the} (n^+ - n^-)$$

$$n^+ - n^- = \left. \frac{dn}{dx} \right|_{x_1} \cdot l_{cc}$$

$$f_c(x_1) = - \underbrace{\frac{1}{2} v_{the} \cdot l_{cc}}_{D_e} \left. \frac{dn}{dx} \right|_{x_1}$$

diffusion coefficient

$$l_{cc} = \frac{\pi}{4} v_{th} \tau_{cc}$$

$$D_e = \frac{1}{2} \cdot v_{the} \cdot l_{cc}$$

and $\mu = \frac{q \cdot l_{cc}}{m_{ice}}$

$$v_{th} = \sqrt{\frac{8KT}{\pi m_{ice}}} \Rightarrow \frac{D_e}{\mu} = \frac{\pi}{8} \cdot \frac{q}{m_{ice}} \cdot \frac{8KT}{\pi m_{ice}} = KT/q$$

$$\begin{cases} f_c = -D_e \cdot \frac{dn}{dx} \\ f_h = -D_h \cdot \frac{dp}{dx} \end{cases}$$

$\therefore$ flux is opposite to $\frac{dn}{dx}$

$\uparrow D$

$\uparrow$ diffusion

Einstein relations

$$\begin{cases} \frac{D_e}{\mu_e} = \frac{KT}{q} \\ \frac{D_h}{\mu_h} = \frac{KT}{q} \end{cases}$$

$[cm^2/s]$

$[cm^2/vs]$

• strength of scattering mechanisms
• the longer l_{cc} , the higher the diffusion flux

D, μ are intimately related to scattering mechanisms.

Exercise

- Estimate electron and hole diffusion coefficients in:

$\left\{ \begin{array}{l} \text{P-type Si at RT} \\ \text{resistivity of } 0.1 \Omega \text{ cm} \end{array} \right.$

$$D_n = \frac{kT}{q} \cdot \mu_n$$

1) Doping level $\Rightarrow N_A$

$$0.1 \Omega \text{ cm} \Rightarrow N_A \approx 3 \times 10^{17} \text{ cm}^{-3}$$

2) μ_h ?

$$\mu_n = 240 \text{ cm}^2/\text{V.s} \Rightarrow D_n = \frac{kT}{q} \mu_n = \frac{26 \text{ mV}}{1e} \cdot \frac{240 \text{ cm}^2}{\text{V.s}} = 6.2 \text{ cm}^2/\text{s}$$

$$\mu_p = 530 \text{ cm}^2/\text{V.s} \Rightarrow D_p = 13.8 \text{ cm}^2/\text{s}$$
